

<b>Notice of References Cited</b>	Application/Control No. 10/814,141		Applicant(s)/Patent Under Reexamination CHO ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0135710	09-2002	Chae, Gee Sung	349/43
*	B	US-2002/0003589	01-2002	Watanabe et al.	349/43
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**FOREIGN PATENT DOCUMENTS**

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